ON Semiconductor

Is Now



To learn more about onsemi™, please visit our website at www.onsemi.com

onsemi and ONSEMI. and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. onsemi owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of onsemi product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. onsemi reserves the right to make changes at any time to any products or information herein is provided "as-is" and onsemi makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using onsemi products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by onsemi. "Typical" parameters which may be provided in onsemi data sheets and/ or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. onsemi does not convey any license under any of its intellectual property rights nor the rights of others. onsemi products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use onsemi products for any such unintended or unauthorized application,



ON Semiconductor®

FDC638APZ

P-Channel 2.5V PowerTrench® Specified MOSFET

–20V, –4.5A, 43mΩ

Features

- Max $r_{DS(on)}$ = 43m Ω at V_{GS} = -4.5V, I_D = -4.5A
- Max $r_{DS(on)}$ = 68m Ω at V_{GS} = -2.5V, I_D = -3.8A
- Low gate charge (8nC typical).
- High performance trench technology for extremely low r_{DS(on)}.
- SuperSOTTM –6 package:small footprint (72% smaller than standard SO–8) low profile (1mm thick).
- RoHS Compliant

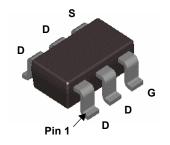
General Description

This P-Channel 2.5V specified MOSFET is produced using ON Semiconductor's advanced PowerTrench® process that has been especially tailored to minimize the on-state resistance and yet maintain low gate charge for superior switching performance

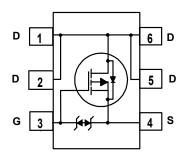
These devices are well suited for battery power applications:load switching and power management,battery charging circuits,and DC/DC conversion.

Application

■ DC - DC Conversion



SuperSOTTM -6



MOSFET Maximum Ratings TA = 25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V_{DS}	Drain to Source Voltage		-20	V
V_{GS}	Gate to Source Voltage		±12	V
	Drain Current -Continuous	(Note 1a)	-4.5	^
^I D	-Pulsed		-20	A
P_{D}	Power Dissipation	(Note 1a)	1.6	W
	Power Dissipation	(Note 1b)	0.8	VV
T _J , T _{STG}	Operating and Storage Junction Temperature Range		-55 to +150	°C

Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	78	°C/W
$R_{\theta,JA}$	Thermal Resistance, Junction to Ambient	(Note 1b)	156	C/VV

Package Marking and Ordering Information

Device Marking	Device	Reel Size	Tape Width	Quantity
.638Z	FDC638APZ	7"	8mm	3000 units

Electrical Characteristics $T_J = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	acteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = -250 \mu A, V_{GS} = 0 V$	-20			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I_D = -250 μ A, referenced to 25°C		-9.4		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = -16V,$ $V_{GS} = 0V$ $T_{J} = 55^{\circ}C$			-1 -10	μА
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 12V, V_{DS} = 0V$			±10	μΑ

On Characteristics

$V_{GS(th)}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = -250 \mu A$	-0.4	-0.8	-1.5	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I_D = -250 μ A, referenced to 25°C		2.9		mV/°C
		$V_{GS} = -4.5V, I_D = -4.5A$		37	43	
r _{DS(on)}	Static Drain to Source On Resistance	$V_{GS} = -2.5V, I_D = -3.8A$		52	68	mΩ
		$V_{GS} = -4.5V$, $I_D = -4.5A$, $T_J = 125$ °C		50	72	
I _{D(on)}	On-State Drain Current	$V_{GS} = -10V, V_{DS} = -4.5A$	-20			Α
9 _{FS}	Forward Transconductance	$V_{DS} = -10V$, $I_{D} = -4.5A$		18		S

Dynamic Characteristics

C _{iss}	Input Capacitance	V _{DS} = -10V, V _{GS} = 0V, f = 1MHz	750	1000	pF
C _{oss}	Output Capacitance		155	210	pF
C _{rss}	Reverse Transfer Capacitance	1 - 111112	130	195	pF

Switching Characteristics (Note 2)

t _{d(on)}	Turn-On Delay Time	.,	6	12	ns
t _r	Rise Time	$V_{DD} = -5V, I_{D} = -4.5A$ $V_{GS} = -4.5V, R_{GEN} = 6\Omega$	20	31	ns
t _{d(off)}	Turn-Off Delay Time	V _{GS} 4.5V, K _{GEN} - 022	48	77	ns
t _f	Fall Time	1	47	72	ns
$Q_{g(TOT)}$	Total Gate Charge	$V_{GS} = 0V \text{ to } -4.5V$ $V_{DD} = -5V$	8	12	nC
Q _{gs}	Gate to Source Gate Charge	I _D = -4.5A	2		nC
Q_{gd}	Gate to Drain "Miller" Charge		2		nC

Drain-Source Diode Characteristics

Is	Maximum Continuous Drain-Source Diode Forward Current			-1.3	Α
V_{SD}	Source to Drain Diode Forward Voltage	$V_{GS} = 0V, I_{S} = -1.3A$ (Note 2)	-0.8	-1.2	V
t _{rr}	Reverse Recovery Time	$I_F = -4.5A$, di/dt = 100A/ μ s	24	36	ns
Q _{rr}	Reverse Recovery Charge		13	20	nC

Notes:

1: R_{0,JA} is the sum of the junction-to-case and case-to-ambient resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.R_{0,JC} is guaranteed by design while R_{0,CA} is determined by user's board design.



a. 78°C/W when mounted on a 1 in2 pad of 2 oz copper on FR-4 board.



b. 156°C/W when mounted on a minimum pad of 2 oz copper.

^{2:} Pulse Test: Pulse Width < $300\mu s$, Duty cycle < 2.0%.

Typical Characteristics T_J = 25°C unless otherwise noted

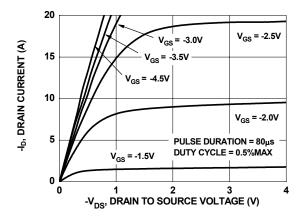


Figure 1. On-Region Characteristics

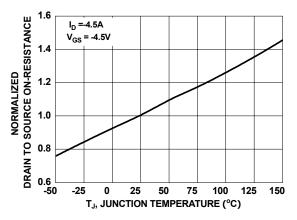


Figure 3. Normalized On-Resistance vs Junction Temperature

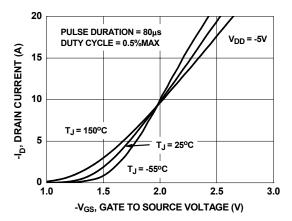


Figure 5. Transfer Characteristics

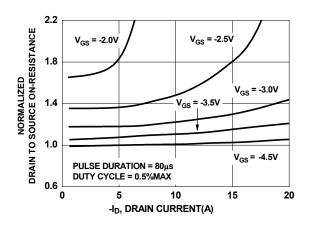


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

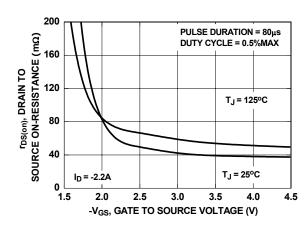


Figure 4. On-Resistance vs Gate to Source Voltage

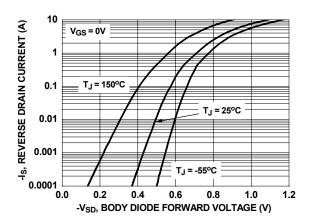


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics $T_J = 25^{\circ}C$ unless otherwise noted

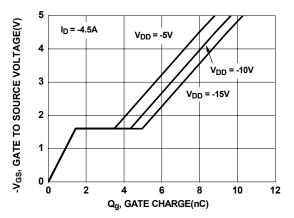


Figure 7. Gate Charge Characteristics

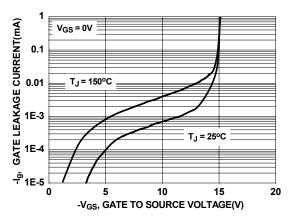


Figure 9. Gate Leakage Current vs Gate to Source Voltage

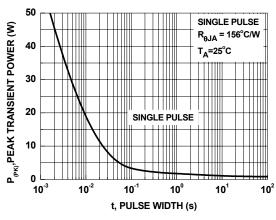


Figure 11. Single Pulse Maximum Power Dissipation

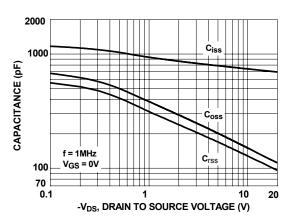


Figure 8. Capacitance vs Drain to Source Voltage

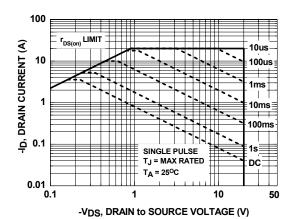


Figure 10. Forward Bias Safe Operating Area

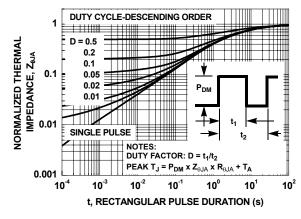


Figure 12. Transient Thermal Response Curve

ON Semiconductor and in are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by ON Semiconductor. "Typical" parameters which may be provided in ON Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights nor the rights of others. ON Semiconductor products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor products for any such unintended or unauthorized application, Buyer shall indemnify and hol

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:

Literature Distribution Center for ON Semiconductor 19521 E. 32nd Pkwy, Aurora, Colorado 80011 USA Phone: 303-675-2175 or 800-344-3860 Toll Free USA/Canada Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada Email: orderlit@onsemi.com N. American Technical Support: 800-282-9855 Toll Free USA/Canada
Europe, Middle East and Africa Technical Support: Phone: 421 33 790 2910

Phone: 81–3–5817–1050

ON Semiconductor Website: www.onsemi.com

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your local Sales Representative